

Notice of References Cited	Application/Control No. 10/825,816	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Chuc D. Tran	Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,806,114	10-2004	Lo, Yu-Hwa	438/36
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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